

**Search Notes**

Application/Control No.

10/562,912

Examiner

SYED ZAIDI

Applicant(s)/Patent under  
Reexamination

YAMAGUCHI, KENJI

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner
455	412	5/22/2008	SZ
455	466	5/22/2008	SZ
455	503	5/22/2008	SZ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (please see search history)	5/22/2008	SZ
Inventor : YAMAGUCHI, KENJI	5/22/2008	SZ
IEEE Xplore Database( <a href="http://ieeexplore.ieee.org/Xplore/DynWel.jsp">http://ieeexplore.ieee.org/Xplore/DynWel.jsp</a> )	5/22/2008	SZ
(455/412 455/466 455/503).ccls.	5/22/2008	SZ
Consulted with SPE Nick Corsaro	5/22/2008	SZ